## Search Notes



# Application/Control No.

10813212

Reexamination

Applicant(s)/Patent Under

QUMEI, IYAD

Examiner

Chen, Shin-Hon

Art Unit

2131

#### **SEARCHED**

Class	Subclass	Date	Examiner

# **SEARCH NOTES**

Search Notes	Date	Examiner
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search - see search history)	6/13/07	S.C.

## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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